

**Search Notes**

Application/Control No.

10/664,097

Examiner

Hien X. Vo

Applicant(s)/Patent under  
Reexamination

JENSEN ET AL.

Art Unit

2863

**SEARCHED**

Class	Subclass	Date	Examiner
702	62, 61	3/16/2005	VXH
	64, 90		
	60		
324	110		
	74-77		
	140R, 141		
	142		
340	657, 658		
	660, 661		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	3/16/2005	VXH